

Notice of References Cited	Application/Control No. 10/064,194	Applicant(s)/Patent Under Reexamination HAAN ET AL.	
	Examiner Michael I Poe	Art Unit 1732	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,768,673	06-1998	Morigami, Yuusuke	399/330
X	B	US-3,912,799	10-1975	Chisholm, Douglas S.	264/403
X	C	US-4,342,714	08-1982	Gregg et al.	264/81
X	D	US-4,435,802	03-1984	Sakamoto et al.	369/286
X	E	US-4,500,484	02-1985	Gregg, David P.	264/107
X	F	US-5,032,703	07-1991	Henschen et al.	219/85.22
X	G	US-5,466,319	11-1995	Zager et al.	156/220
X	H	US-6,528,771	03-2003	Matsen et al.	219/634
X	I	US-2004/0041303 A1	03-2004	Kim et al.	264/320
X	J	US-2004/0150135 A1	08-2004	Hennessey et al.	264/293
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 02182433 A	07-1990	Japan	ARISAWA et al.	B29C 59/02
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Derwent Abstract of JP 02-182433 A, 1990, Derwent Information Limited, Derwent Week # 199034.
	V	Derwent Abstract of SU 1344481 A, 1988, Derwent Information Limited, Derwent Week # 198819.
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.